

# HGA277/HGA2277/HGA4277 High Precision Operational Amplifiers

# 1 Features

- Ultralow Offset Voltage: 10 μV
- Ultralow Drift: ±0.1 µV/°C
- High Open-Loop Gain: 134 dB
- High Common-Mode Rejection: 140 dB
- High Power Supply Rejection: 130 dB
- Low Bias Current: 1-nA maximum
- Wide Supply Range: ±2 V to ±18 V
- Low Quiescent Current: 800 µA/amplifier
- Single, Dual, and Quad Versions

# 2 Applications

- Transducer Amplifiers
- Bridge Amplifiers
- Temperature Measurements
- Strain Gage Amplifiers
- Precision Integrators
- Battery-Powered Instruments
- Test Equipment

## **3** Description

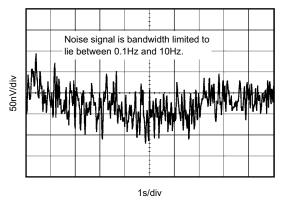
The HGAx277 series precision operational amplifiers replace the industry standard HG-177. They offer improved noise, wider output voltage swing, and are twice as fast with half the quiescent current. Features include ultralow offset voltage and drift, low bias current, high common-mode rejection, and high power supply rejection. Single, dual, and quad versions have identical specifications, for maximum design flexibility. HGAx277 series operational amplifiers operate from  $\pm 2$ -V to  $\pm 18$ -V supplies with excellent performance. Unlike most operational amplifiers which are specified at only one supply voltage, the HGAx277 series is specified for real-world applications; a single limit applies over the  $\pm 5$ -V to  $\pm 15$ -V supply range. High performance is maintained as the amplifiers swing to their specified limits. Because the initial offset voltage ( $\pm 20 \ \mu$ V maximum) is so low, user adjustment is usually not required. However, the single version (HGA277) provides external trim pins for special applications.

HGA277operational amplifiers are easy to use and free from phase inversion and the overload problems found in some other operational amplifiers. They are stable in unity gain and provide excellent dynamic behavior over a wide range of load conditions. Dual and quad versions feature completely independent circuitry for lowest crosstalk and freedom from interaction, even when overdriven or overloaded.

L	Device Information '						
PART NUMBER	PACKAGE	BODY SIZE (NOM)					
HGA277 HGA2277	VSON (8)	4.00 mm × 4.00 mm					
	SOIC (8)	3.91 mm × 4.90 mm					
TION LET T	PDIP (8)	6.35 mm × 9.81 mm					
HGA4277	SOIC (14)	3.91 mm × 8.65 mm					
HGA4277	PDIP (14)	6.35 mm × 19.30 mm					

Device Information<sup>(1)</sup>

(1) For all available packages, see the orderable addendum at the end of the data sheet.

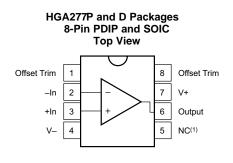


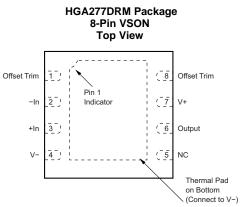
#### 0.1 Hz to 10 Hz Noise



# HGA277/HGA2277/HGA4277

# 4 Pin Configuration and Functions

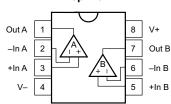


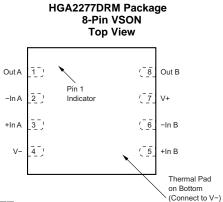


#### **Pin Functions: HGA277**

PIN           NO.         NAME           1         Offset Trim		1/0	DESCRIPTION		
		I/O			
		I	Input offset voltage trim (leave floating if not used)		
2	–In	I	I Inverting input		
3	+In	I	Noninverting input		
4	V-	_	Negative (lowest) power supply		
5	NC	_	No internal connection (can be left floating)		
6	Output	0	Output		
7	V+	_	Positive (highest) power supply		
8	Offset Trim		Input offset voltage trim (leave floating if not used)		

#### HGA2277P and D Packages 8-Pin PDIP and SOIC Top View

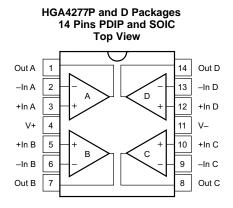




#### Pin Functions: HGA2277

	PIN			
NAME	PDIP, SOIC NO.	DFN NO.	I/O	DESCRIPTION
Out A	1	1	0	Output channel A
–In A	2	2	Η	Inverting input channel A
+In A	3	3	Ι	Noninverting input channel A
V–	4	4	_	Negative (lowest) power supply
+ln B	5	5	Ι	Noninverting input channel B
–In B	6	6	Η	Inverting input channel B
Out B	7	8	0	Output channel B
V+	8	7	_	Positive (highest) power supply





#### Pin Functions: HGA4277

	PIN	1/0	DESCRIPTION		
NO.	NAME	I/O	DESCRIPTION		
1	Out A	0	Output channel A		
2	–In A	I	Inverting input channel A		
3	+In A	I	Noninverting input channel A		
4	V+	_	Positive (highest) power supply		
5	+In B	I	Noninverting input channel B		
6	–In B	I	Inverting input channel B		
7	Out B	0	Output channel B		
8	Out C	0	Output channel C		
9	–In C	I	Inverting input channel C		
10	+In C	I	Noninverting input channel C		
11	V–	_	Negative (lowest) power supply		
12	+In D	I	Noninverting input channel D		
13	–In D	I	Inverting input channel D		
14	Out D	0	Output channel D		



## **5** Specifications

## 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

	MIN	MAX	UNIT
Supply voltage, $Vs = (V+) - (V-)$		36	V
Input voltage	(V–) –0.7	(V+) +0.7	V
Output short-circuit <sup>(2)</sup>	Conti	nuous	
Operating temperature	-55	125	°C
Junction temperature		150	°C
Lead temperature		300	°C
Storage temperature, T <sub>stg</sub>	-55	125	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Short-circuit to ground, one amplifier per package.

## 5.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22- $\rm C101^{(2)}$	±500	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	NOM	MAX	UNIT
Supply voltage, $Vs = (V+) - (V-)$	4 (±2)	30 (±15)	36 (±18)	V
Specified temperature	-40		+85	°C

#### 5.4 Thermal Information for HGA277

		HGA277					
	THERMAL METRIC <sup>(1)</sup>	P (PDIP)	D (SOIC)	DRM (VSON)	UNIT		
			8 PINS				
R <sub>0JA</sub>	Junction-to-ambient thermal resistance	49.2	110.1	40.7	°C/W		
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	39.4	52.2	41.3	°C/W		
$R_{\theta JB}$	Junction-to-board thermal resistance	26.4	52.3	16.7	°C/W		
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	15.4	10.4	0.6	°C/W		
$\Psi_{JB}$	Junction-to-board characterization parameter	26.3	51.5	16.9	°C/W		
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	—	—	3.3	°C/W		

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

## 5.5 Thermal Information for HGA2277

			HGA2277		
	THERMAL METRIC <sup>(1)</sup>	P (PDIP)	D (SOIC)	DRM (VSON)	UNIT
			8 PINS		
$R_{\thetaJA}$	Junction-to-ambient thermal resistance	47.2	107.4	39.3	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	36.0	45.8	36.9	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.



# Thermal Information for HGA277 (continued)

			HGA2277		
	THERMAL METRIC <sup>(1)</sup>	P (PDIP)	D (SOIC)	DRM (VSON)	UNIT
			8 PINS		
$R_{\theta JB}$	Junction-to-board thermal resistance	24.4	47.9	15.4	°C/W
Ψյт	Junction-to-top characterization parameter	13.4	5.7	0.4	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	24.3	47.3	15.6	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	—	—	2.2	°C/W

## 5.6 Thermal Information for HGA4277

		HGA	4277	
	THERMAL METRIC <sup>(1)</sup>	D (SOIC)	P (PDIP)	UNIT
		14 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	67.0	66.3	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	24.1	20.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	22.5	26.8	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	2.2	2.1	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	22.1	26.2	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	—	—	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

## 5.7 Electrical Characteristics for HGAx277P, HGAx277U, and HGAx277xA

At  $T_A = 25^{\circ}$ C, and  $R_L = 2 \text{ k}\Omega$ , unless otherwise noted

	PARAMETER		TEST CONDITIONS	HGA277P,U HGA2277P,U			HGA277xA HGA2277xA HGA4277xA			UNIT
				MIN	TYP <sup>(1)</sup>	MAX	MIN	TYP <sup>(1)</sup>	MAX	
OFFSET VOLTAGE										
V <sub>0S</sub>	Input Offset Vol	tage			±10	±20		±20	±50	μV
		HGA277P,U (high-grade, single)				±30				
	Input Offset Voltage Over	HGA2277P,U (high-grade, dual)	T <sub>A</sub> = −40°C to 85°C			±50				μV
	Temperature	All PA, UA, Versions							±100	
		AIDRM Versions	1							
		HGA277P,U (high-grade, single)			±0.1	±0.15				μV/°C
dV <sub>0S</sub> /dT	Input Offset Voltage Drift	HGA2277P,U (high-grade, dual)	T <sub>A</sub> = -40°C to 85°C		±0.1	±0.25				
		All PA, UA, AIDRM Versions						±0.15	±1	
		vs Time			0.2			See (2)		µV/mo
	Input Offset Voltage: (all	vs Power Supply	$V_{S} = \pm 2 V \text{ to } \pm 18 V$		±0.3	±0.5		See (2)	±1	
mo	models)	(PSRR)	T <sub>A</sub> = -40°C to 85°C			±0.5			±1	μV/V
	Channel Separa	ation (dual, quad)	DC		0.1			See (2)		μV/V

(1)  $V_{S} = \pm 15 V$ 

(2) Specifications are the same as HGA277P,U.



At  $T_{\text{A}}$  = 25°C, and  $R_{\text{L}}$  = 2 k $\Omega,$  unless otherwise noted

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	PARAMETER		TEST CONDITIONS	HGA277P,U HGA2277P,U		HGA277xA HGA2277xA HGA4277xA			UNIT	
				MIN	TYP <sup>(1)</sup>	МАХ	MIN	TYP <sup>(1)</sup>	MAX	
INPUT BI	AS CURRENT									
IB	Input Bias Curre	ont	$T_A = -40^{\circ}C$ to		±0.5	±1		See (2)	±2.8	nA
в			85°C			±2			±4	10.0
l <sub>os</sub>	Input Offset Cur	rent	$T_A = -40^{\circ}C$ to		±0.5	±1		See (2)	±2.8	nA
105		Ion	85°C			±2			±4	10.0
NOISE										
	Input Voltage No	oise, f = 0.1 to 10 Hz			0.22			See (2)		$\mu V_{PP}$
		f = 10 Hz	_		12			See (2)		
e <sub>n</sub>	Input Voltage	f = 100 Hz	_		8			See (2)		nV/√Hz
-11	Noise Density	f = 1 kHz	_		8			See (2)		,
		f = 10 kHz			8			See (2)		
i <sub>n</sub>		ensity, f = 1 kHz			0.2			See (2)		pA/√Hz
	DLTAGE RANGE		1						T	
V <sub>CM</sub>	Common-Mode	Voltage Range	ļ	(V–)+2		(V+)–2	See (2)		See (2)	V
CMRR	Common-Mode	Rejection	V <sub>CM</sub> = (V–) +2 V to (V+) –2 V	130	140		115	See (2)		dB
OMINI			T <sub>A</sub> = −40°C to 85°C	128			115			
INPUT IM	PEDANCE									
	Differential				100    3			See (2)		MΩ    pF
	Common-Mode		$V_{CM} = (V-) +2 V$ to (V+) -2 V		250    3			See (2)		GΩ    pF
OPEN-LO	OP GAIN									
			V <sub>O</sub> = (V–)+0.5 V							
			to (V+)–1.2 V, R <sub>L</sub> = 10 kΩ		140			See (2)		
A <sub>OL</sub>	Open-Loop Volt	age Gain	V <sub>O</sub> = (V–)+1.5 V							dB
			to (V+)–1.5 V, R <sub>L</sub> = 2 kΩ	126	134		See (2)	See (2)		
			$V_0 = (V_{-}) + 1.5 V$							
			to							
			(V+)–1.5 V, R <sub>L</sub> = 2 kΩ	126			See (2)			dB
			$T_{A} = -40^{\circ}C \text{ to}$ 85°C							
FREQUE	NCY RESPONSE		-1							
GBW	Gain-Bandwidth	Product			1			See (2)		MHz
SR	Slew Rate				0.8			See (2)		V/µs
		0.1%	V <sub>S</sub> = ±15 V,		14			See (2)		
	Settling Time	0.01%	G = 1, 10-V Step		16			See (2)		μs
	Overload Recov	very Time	$V_{IN} \times G = V_S$		3			See (2)		μs
THD+N		Distortion + Noise	1 kHz, G = 1, $V_0 = 3.5$ Vrms		0.002%			See (2)		r -



# Electrical Characteristics for HGAx277P, HGA2277U, and HGAx277xA(continued)

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At T_{A} = 25°C, and R_{L} = 2 k\Omega, unless otherwise noted
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	PARAMETER	TEST CONDITIONS	HGA277PU HGA2277PU			HGA277xA HGA2277xA HGA4277xA			UNIT	
			MIN	TYP <sup>(1)</sup>	MAX	MIN	TYP <sup>(1)</sup>	MAX		
OUTPUT	г							·		
		$R_L = 10 \ k\Omega$	(V–)+0.5		(V+)-1.2	See (2)		See (2)		
Vo	Valtare Outruit	T <sub>A</sub> = -40°C to +85°C	(V–)+0.5		(V+)-1.2	See (2)		See (2)	V	
	Voltage Output	$R_L = 2 k\Omega$	(V–)+1.5		(V+)-1.5	See (2)		See (2)		
		T <sub>A</sub> = -40°C to +85°C	(V–)+1.5		(V+)–1.5	See (2)		See (2)		
I <sub>SC</sub>	Short-Circuit Current			±35			See (2)		mA	
CLOAD	Capacitive Load Drive			See (3)						
Zo	Open-loop output impedance	f = 1 MHz		40			See (2)		Ω	
POWER	SUPPLY									
Vs	Specified Voltage Range		±5		±15	See (2)		See (2)	V	
	Operating Voltage Range		<u>+2</u>		±18	See (2)		See (2)	V	
		I <sub>O</sub> = 0		±790	±825		See (2)	See (2)		
lq	Quiescent Current (per amplifier)	$T_A = -40^{\circ}C$ to 85°C			±900			See (2)	μA	
TEMPER	RATURE RANGE							I		
	Specified Range		-40		85	See (2)		See (2)	°C	
	Operating Range		-55		125	See (2)		See (2)	°C	

(3) See Typical Characteristics

# 6.8 Electrical Characteristics for HGAx277AIDRM

At  $T_A = 25^{\circ}$ C, and  $R_L = 2 \text{ k}\Omega$ , unless otherwise noted

PARAMETER		TEST CONDITIONS	HGA277AIDRM HGA2277AIDRM			UNIT	
			MIN	TYP <sup>(1)</sup>	MAX		
OFFSET VC	DLTAGE						
V <sub>0S</sub>	Input Offset Voltage				±35	±100	μV
		HGA277P,U (high-grade, single)					
	Input Offset Voltage Over Temperature	HGA2277P,U (high-grade, dual)	$T_{A} = -40^{\circ}C \text{ to } 85^{\circ}C$				μV
	·	All PA, UA, Versions					
		AIDRM Versions				±165	
	Input Offset Voltage Drift Input Offset Voltage: (all models)	HGA277P,U (high-grade, single)	$T_A = -40^{\circ}C \text{ to } 85^{\circ}C$				
dV <sub>0S</sub> /dT		HGA2277PU (high-grade, dual)					µV/°C
		All PA, UA, AIDRM Versions			±0.15	±1	
		vs Time			See (2)		µV/mo
			$V_{S} = \pm 2 \text{ V to } \pm 18 \text{ V}$	See <sup>(2)</sup> ±1		μV/V	
		vs rower supply (PSRR)	$T_A = -40^{\circ}C$ to $85^{\circ}C$	±	±1	μν/ν	
	Channel Separation (dual, quad)		DC		See (2)		μV/V

(1)  $V_S = \pm 15 V$ (2) Specifications are the same as HGA277P, U.



# Electrical Characteristics for HGAx277AIDRM (continued)

At  $T_{\text{A}}$  = 25°C, and  $R_{\text{L}}$  = 2 k $\Omega$ , unless otherwise noted

	PARAMETI	ER	TEST CONDITIONS	HGA277AIDRM HGA2277AIDRM			UNIT
				MIN	TYP <sup>(1)</sup>	MAX	
NPUT BIAS	CURRENT		1				
I <sub>B</sub>	Input Bias Current		$T_A = -40^{\circ}C \text{ to } 85^{\circ}C$	±2.8 ±4			nA
los	Input Offset Current		$T_A = -40^{\circ}C \text{ to } 85^{\circ}C$			±2.8 ±4	nA
NOISE							
	Input Voltage Noise, f	= 0.1 to 10 Hz			See (2)		μV <sub>PP</sub>
		f = 10 Hz			See (2)		
	Input Voltage Noise	f = 100 Hz			See (2)		
e <sub>n</sub>	Density	f = 1 kHz			See (2)		nV/√Hz
		f = 10 kHz			See (2)		
n	Current Noise Density	, f = 1 kHz			See (2)		pA/√Hz
NPUT VOL	TAGE RANGE						
V <sub>CM</sub>	Common-Mode Voltag	e Range		See (2)		See (2)	V
CMRR	Common-Mode Reject	ion	$V_{CM} = (V-) + 2 V$ to (V+) -2 V	115	See (2)		dB
	·		$T_A = -40^{\circ}C$ to $85^{\circ}C$	115			
	DANCE						
	Differential				See (2)		MΩ    pF
	Common-Mode		$V_{CM} = (V-) + 2 V$ to (V+) -2 V		See (2)		GΩ∥pF
OPEN-LOO	P GAIN		1				
	Open-Loop Voltage Gain		$V_{O} = (V-)+0.5 V$ to (V+)-1.2 V, R <sub>L</sub> = 10 kΩ		See (2)		
A <sub>OL</sub>			$V_{O} = (V-)+1.5 V$ to (V+)-1.5 V, $R_{L} = 2 k\Omega$	See (2)	See (2)		dB
				See <sup>(2)</sup>			dB
			$T_A = -40^{\circ}C$ to $85^{\circ}C$				
REQUENC	Y RESPONSE					l.	
GBW	Gain-Bandwidth Produ	ict			See (2)		MHz
SR	Slew Rate	1			See (2)		V/µs
	Cottling Time	0.1%	$V_{S} = \pm 15 V,$		See (2)		
	Settling Time	0.01%	G = 1, 10-V Step		See (2)		μs
	Overload Recovery Tir	ne	$V_{IN} \times G = V_S$		See (2)		μs
THD+N	Total Harmonic Distortion + Noise		1 kHz, G = 1, $V_0 = 3.5$ Vrms		See (2)		
OUTPUT							
	Voltage Output		$R_L = 10 \ k\Omega$	See (2)		See (2)	
			$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	See (2)		See (2)	
Vo			$R_L = 2 k\Omega$	See (2)		See (2)	V
			$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	See (2)		See (2)	
I <sub>SC</sub>	Short-Circuit Current				See (2)		mA
C <sub>LOAD</sub>	Capacitive Load Drive						
Z <sub>O</sub>	Open-loop output impe	edance	f = 1 MHz		See (2)		Ω



## Electrical Characteristics for HGAx277AIDRM (continued)

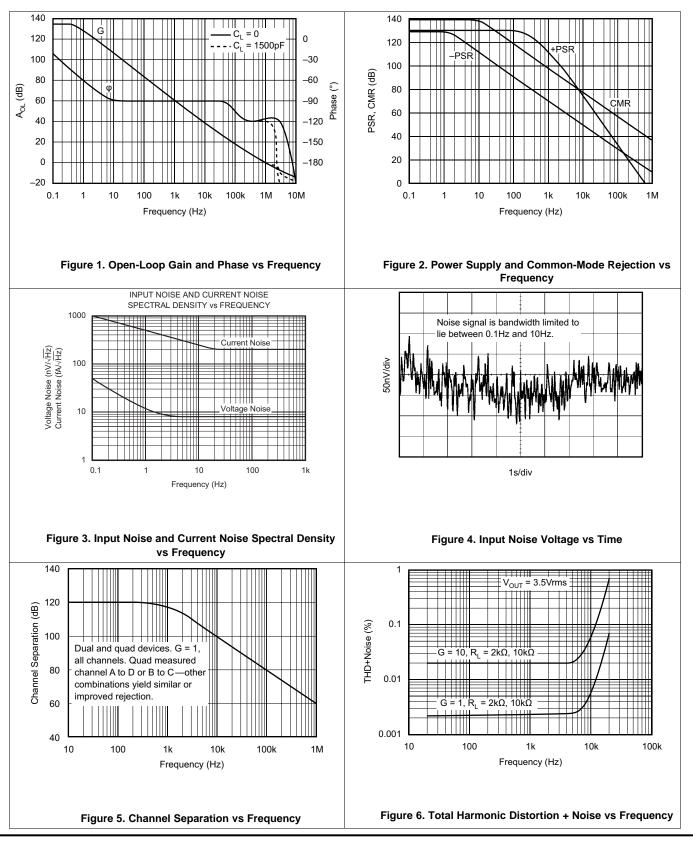
At  $T_{A}$  = 25°C, and  $R_{L}$  = 2 k\Omega, unless otherwise noted

PARAMETER		TEST CONDITIONS	HGA277AIDRM HGA2277AIDRM			UNIT
			MIN	TYP <sup>(1)</sup>	MAX	
POWER	SUPPLY					
Vs	Specified Voltage Range		See (2)		See (2)	V
	Operating Voltage Range		See (2)		See (2)	V
l <sub>Q</sub>		I <sub>O</sub> = 0		See (2)	See (2)	
	Quiescent Current (per amplifier)	$T_A = -40^{\circ}C$ to $85^{\circ}C$	See			μA
TEMPER	ATURE RANGE	· · · · ·				
	Specified Range		See (2)		See (2)	°C
	Operating Range		See (2)		See (2)	°C



## 6.9 Typical Characteristics

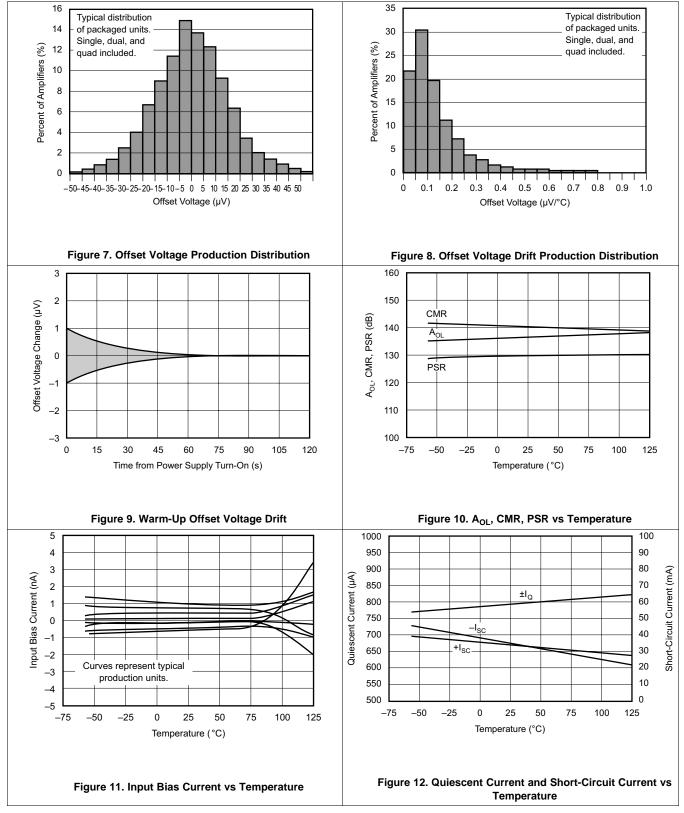
At  $T_A = 25^{\circ}C$ ,  $V_S = \pm 15$  V, and  $R_L = 2$  k $\Omega$ , unless otherwise noted.





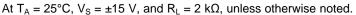
# **Typical Characteristics (continued)**

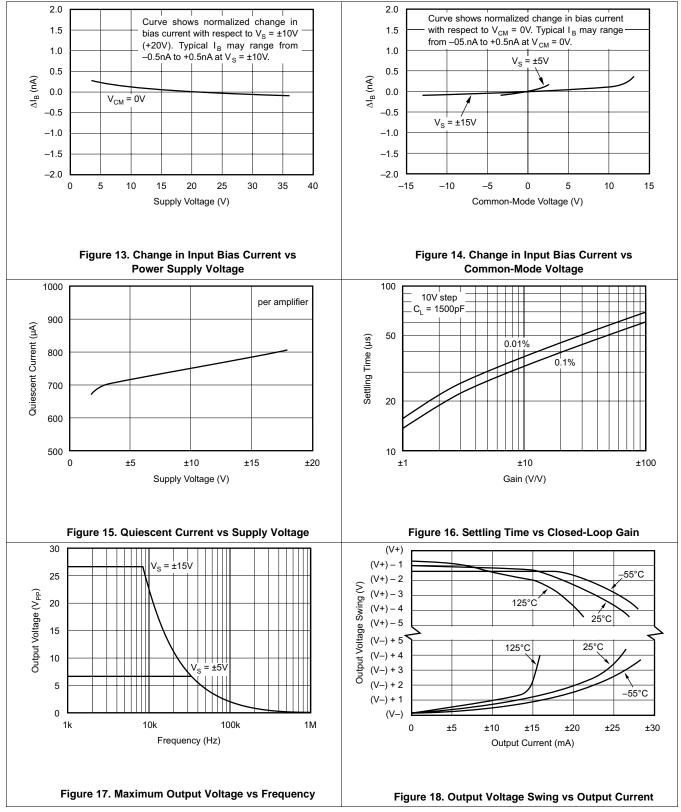






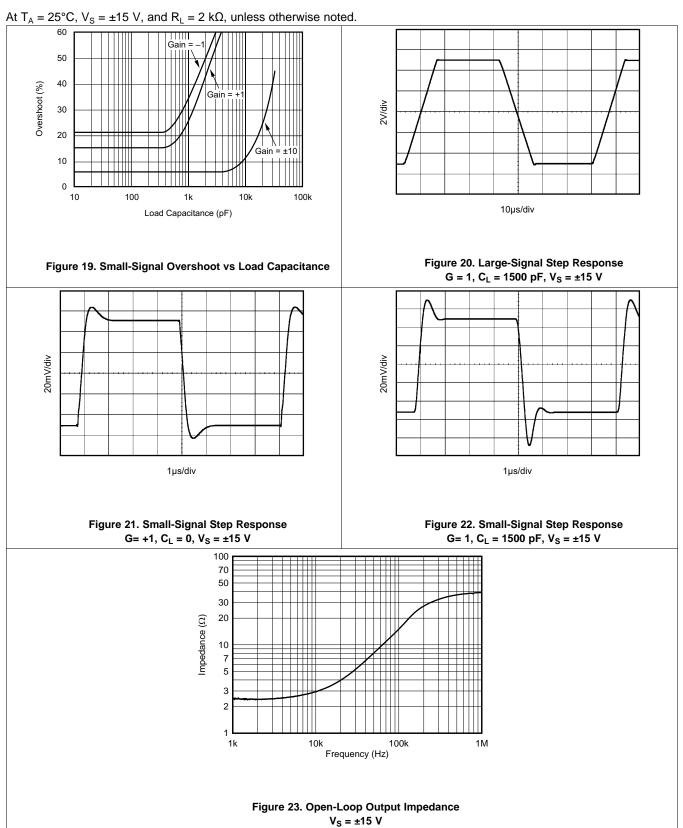
## **Typical Characteristics (continued)**







## **Typical Characteristics (continued)**



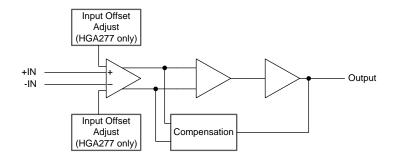


# 7 Detailed Description

## 7.1 Overview

The HGAx27 series precision operational amplifiers replace the industry standard HG-177. They offer improved noise, wider output voltage swing, and are twice as fast with half the quiescent current. Features include ultralow offset voltage and drift, low bias current, high common-mode rejection, and high power supply rejection. Single, dual, and quad versions have identical specifications, for maximum design flexibility.

## 7.2 Functional Block Diagram



## 7.3 Feature Description

The HGAx277series is unity-gain stable and free from unexpected output phase reversal, making it easy to use in a wide range of applications. Applications with noisy or high-impedance power supplies may require decoupling capacitors close to the device pins. In most cases 0.1-µF capacitors are adequate.

The HGAx277 series has low offset voltage and drift. To achieve highest performance, the circuit layout and mechanical conditions should be optimized. Offset voltage and drift can be degraded by small thermoelectric potentials at the operational amplifier inputs. Connections of dissimilar metals generate thermal potential, which can degrade the ultimate performance of the HGAx277 series. These thermal potentials can be made to cancel by assuring that they are equal in both input terminals.

- Keep the thermal mass of the connections to the two input terminals similar
- · Locate heat sources as far as possible from the critical input circuitry
- Shield operational amplifier and input circuitry from air currents, such as cooling fans

## 7.3.1 Operating Voltage

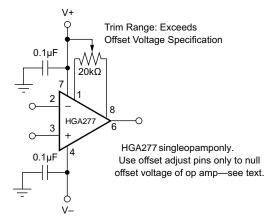
HGAx277series operational amplifiers operate from ±2-V to ±18-V supplies with excellent performance. Unlike most operational amplifiers, which are specified at only one supply voltage, the HGA277 series is specified for real-world applications; a single limit applies over the ±5-V to ±15-V supply range. This allows a customer operating at  $V_s = \pm 10$  V to have the same assured performance as a customer using ±15-V supplies. In addition, key parameters are assured over the specified temperature range, -40°C to 85°C. Most behavior remains unchanged through the full operating voltage range (±2 V to ±18 V). Parameters which vary significantly with operating voltage or temperature are shown in *Typical Characteristics*.

#### 7.3.2 Offset Voltage Adjustment

The HGAx277series is laser-trimmed for low offset voltage and drift, so most circuits do not require external adjustment. However, offset voltage trim connections are provided on pins 1 and 8. Offset voltage can be adjusted by connecting a potentiometer, as shown in Figure 24. Only use this adjustment to null the offset of the operational amplifier. This adjustment should not be used to compensate for offsets created elsewhere in a system, because this can introduce additional temperature drift.



## Feature Description (continued)





#### 7.3.3 Input Protection

The inputs of the HGAx277 series are protected with  $1-k\Omega$  series input resistors and diode clamps. The inputs can withstand ±30-V differential inputs without damage. The protection diodes conduct current when the inputs are over-driven. This may disturb the slewing behavior of unity-gain follower applications, but will not damage the operational amplifier.

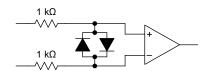
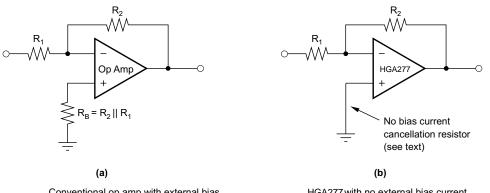


Figure 25. HGAx277 Input Protection

#### 7.3.4 Input Bias Current Cancellation

The input stage base current of the HGAx277 series is internally compensated with an equal and opposite cancellation circuit. The resulting input bias current is the difference between the input stage base current and the cancellation current. This residual input bias current can be positive or negative.

When the bias current is canceled in this manner, the input bias current and input offset current are approximately the same magnitude. As a result, it is not necessary to use a bias current cancellation resistor, as is often done with other operational amplifiers (see Figure 26). A resistor added to cancel input bias current errors may actually increase offset voltage and noise.



Conventional op amp with external bias current cancellation resistor.

HGA277 with no external bias current cancellation resistor.

#### Figure 26. Input Bias Current Cancellation



## Feature Description (continued)

#### 7.3.5 EMI Rejection Ratio (EMIRR)

The electromagnetic interference (EMI) rejection ratio, or EMIRR, describes the EMI immunity of operational amplifiers. An adverse effect that is common to many operational amplifiers is a change in the offset voltage as a result of RF signal rectification. An operational amplifier that is more efficient at rejecting this change in offset as a result of EMI has a higher EMIRR and is quantified by a decibel value. Measuring EMIRR can be performed in many ways, but this report provides the EMIRR IN+, which specifically describes the EMIRR performance when the RF signal is applied to the noninverting input pin of the operational amplifier. In general, only the noninverting input is tested for EMIRR for the following three reasons:

- 1. Operational amplifier input pins are known to be the most sensitive to EMI, and typically rectify RF signals better than the supply or output pins.
- 2. The noninverting and inverting operational amplifier inputs have symmetrical physical layouts and exhibit nearly matching EMIRR performance.
- 3. EMIRR is easier to measure on noninverting pins than on other pins because the noninverting input terminal can be isolated on a printed circuit board (PCB). This isolation allows the RF signal to be applied directly to the noninverting input terminal with no complex interactions from other components or connecting PCB traces.

A more formal discussion of the EMIRR IN+ definition and test method is provided in application report SBOA128, *EMI Rejection Ratio of Operational Amplifiers*, available for download at www.ti.com. The EMIRR IN+ of the OPA277 is plotted versus frequency as shown in Figure 27.

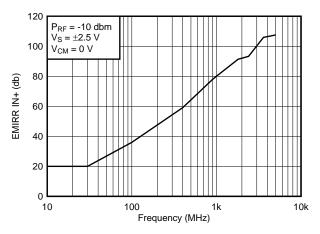


Figure 27. HGA277 EMIRR IN+ vs Frequency

If available, any dual and quad operational amplifier device versions have nearly similar EMIRR IN+ performance. The HGA277 unity-gain bandwidth is 1 MHz. EMIRR performance below this frequency denotes interfering signals that fall within the operational amplifier bandwidth.



## Feature Description (continued)

Table 1 shows the EMIRR IN+ values for the HGA277at particular frequencies commonly encountered in realworld applications. Applications listed in Table 1 may be centered on or operated near the particular frequency shown. This information may be of special interest to designers working with these types of applications, or working in other fields likely to encounter RF interference from broad sources, such as the industrial, scientific, and medical (ISM) radio band.

	-	
FREQUENCY	APPLICATION/ALLOCATION	EMIRR IN+
400 MHz	Mobile radio, mobile satellite/space operation, weather, radar, UHF	59.1 dB
900 MHz	GSM, radio com/nav./GPS (to 1.6 GHz), ISM, aeronautical mobile, UHF	77.9 dB
1.8 GHz	GSM, mobile personal comm. broadband, satellite, L-band	91.3 dB
2.4 GHz	802.11b/g/n, Bluetooth <sup>™</sup> , mobile personal comm., ISM, amateur radio/satellite, S-band	93.3 dB
3.6 GHz	Radiolocation, aero comm./nav., satellite, mobile, S-band	105.9 dB
5.0 GHz	802.11a/n, aero comm./nav., mobile comm., space/satellite operation, C-band	107.5 dB

#### Table 1. HGA277 EMIRR IN+ for Frequencies of Interest

#### 7.3.5.1 EMIRR IN+ Test Configuration

Figure 28 shows the circuit configuration for testing the EMIRR IN+. An RF source is connected to the operational amplifier noninverting input terminal using a transmission line. The operational amplifier is configured in a unity gain buffer topology with the output connected to a low-pass filter (LPF) and a digital multimeter (DMM). Note that a large impedance mismatch at the operational amplifier input causes a voltage reflection; however, this effect is characterized and accounted for when determining the EMIRR IN+. The resulting dc offset voltage is sampled and measured by the multimeter. The LPF isolates the multimeter from residual RF signals that may interfere with multimeter accuracy. Refer to SBOA128 for more details.

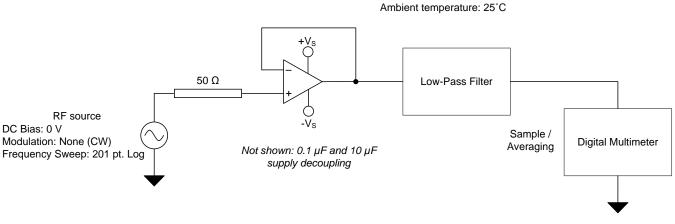


Figure 28. EMIRR IN+ Test Configuration Schematic

## 7.4 Device Functional Modes

The HGAx277 has a single functional mode and is operational when the power-supply voltage is greater than 4 V ( $\pm$ 2 V). The maximum power supply voltage for the HGAx277 is 36 V ( $\pm$ 18 V).



# 8 Application and Implementation

## 8.1 Application Information

The HGAx277 family offers outstanding dc precision and ac performance. These devices operate up to 36-V supply rails and offer ultralow offset voltage and offset voltage drift, as well as 1-MHz bandwidth and high capacitive load drive. These features make the HGAx277 a robust, high-performance operational amplifier for high-voltage industrial applications.

## 8.2 Typical Applications

#### 8.2.1 Second-Order Lowpass Filter

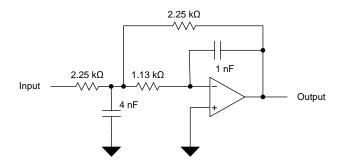


Figure 29. Second-Order Lowpass Filter

#### 8.2.1.1 Design Requirements

- Gain = 1 V/V
- Lowpass cutoff frequency = 50 kHz
- –40 db/dec filter response
- Maintain less than 3-dB gain peaking in the gain versus frequency response

#### 8.2.1.2 Detailed Design Procedure

WEBENCH® Filter Designer is a simple, powerful, and easy-to-use active filter design program. The WEBENCH Filter Designer lets you create optimized filter designs using a selection of TI operational amplifiers and passive components from TI's vendor partners.

Available as a web based tool from the WEBENCH® Design Center, WEBENCH® Filter Designer allows you to design, optimize, and simulate complete multistage active filter solutions within minutes.



# **Typical Applications (continued)**

8.2.1.3 Application Curve

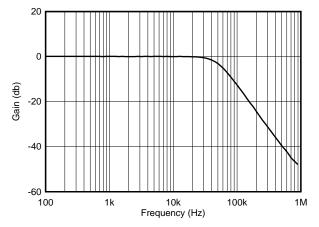
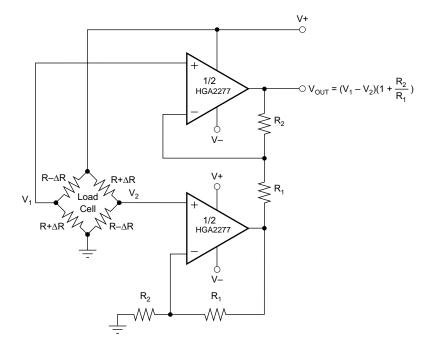
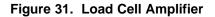


Figure 30. HGA277 Second-Order 50-kHz, Lowpass Filter

#### 8.2.2 Load Cell Amplifier



For integrated solution see: INA126, INA2126 (dual) INA125 (on-board reference) INA122 (single-supply)





## **Typical Applications (continued)**

8.2.3 Thermocouple Low-Offset, Low-Drift Loop Measurement With Diode Cold Junction Compensation

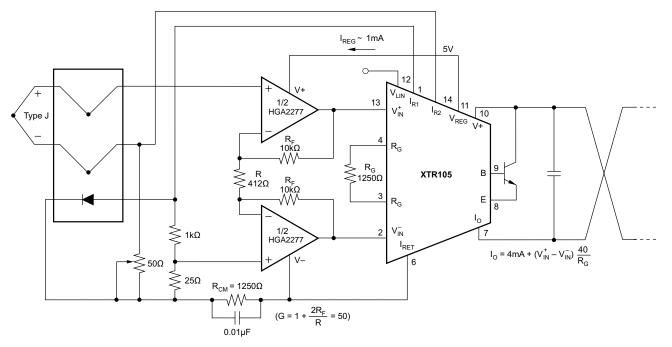


Figure 32. Thermocouple Low-Offset, Low-Drift Loop Measurement With Diode Cold Junction Compensation

#### 10.3 DFN Package

The HGAx277series uses the 8-lead DFN (also known as SON), a QFN package with contacts on only two sides of the package bottom. This leadless, near-chip-scale package maximizes board space and enhances thermal and electrical characteristics through an exposed pad.

DFN packages are physically small, have a smaller routing area, improved thermal performance, and improved electrical parasitics, with a pinout scheme that is consistent with other commonly-used packages, such as SO and MSOP. Additionally, the absence of external leads eliminates bent-lead issues.

The DFN package can be easily mounted using standard printed-circuit-board (PCB) assembly techniques. See *QFN/SON PCB Attachment* (SLUA271) and *Quad Flatpack No-Lead Logic Packages* (SCBA017), both available for download at www.ti.com.

The exposed leadframe die pad on the bottom of the package should be connected to V-.